

Embedded System Random Performance Issue

하이닉스 반도체(주)

Contents

- **Trend of storage device market**
- **Trend of NAND flash tech**
- **How to increase random performance?**
 - **Software side**
 - **Hardware side**

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Random IOPS in mobile phone

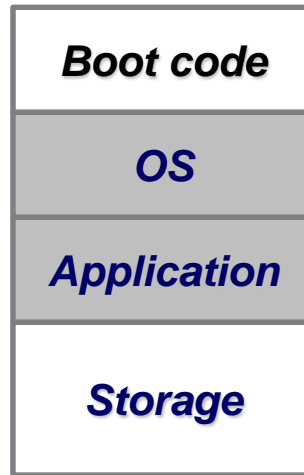
Smartphone OS의 경우 작은 File size Access가 빈번하게 일어나며
Random IOPS 가 Mobile system의 Key factor 임.

Why Random IOPS

Conventional



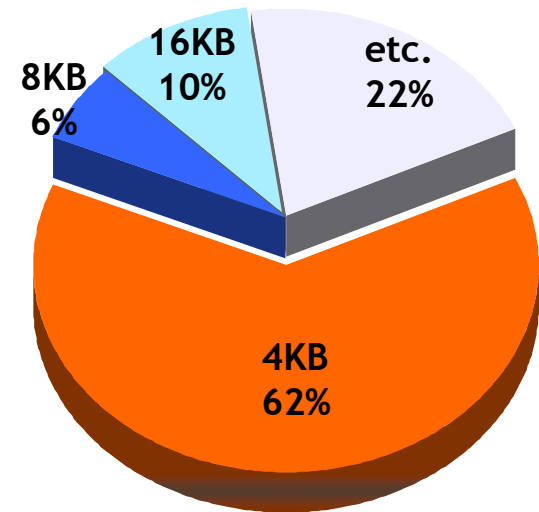
New



4KB random access가 빈번하게 일어나는 영역

IOPS: 초당 NAND에 Access할 수 있는 횟수

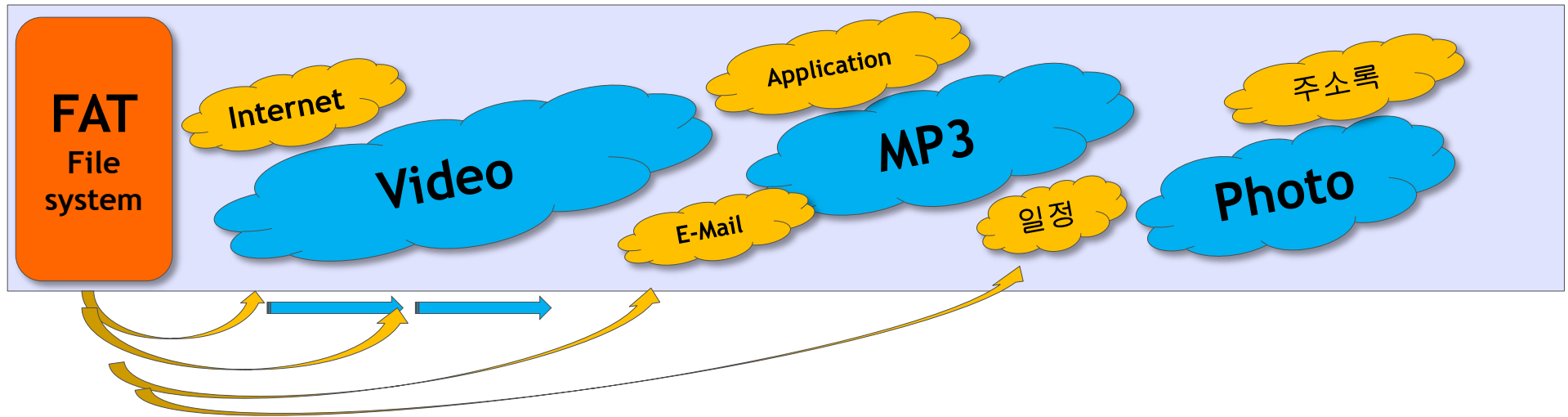
IO Behavior in Smartphone



* 4KB Random IOPS가 Performance 주요 Key Factor임.

Source: Intel Mobile platform

User operation



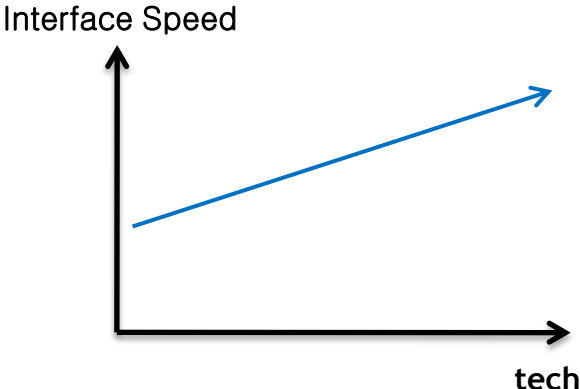
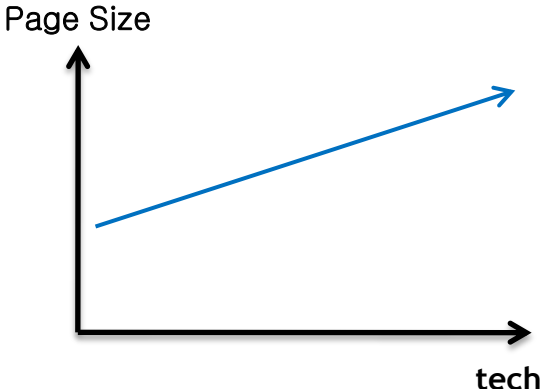
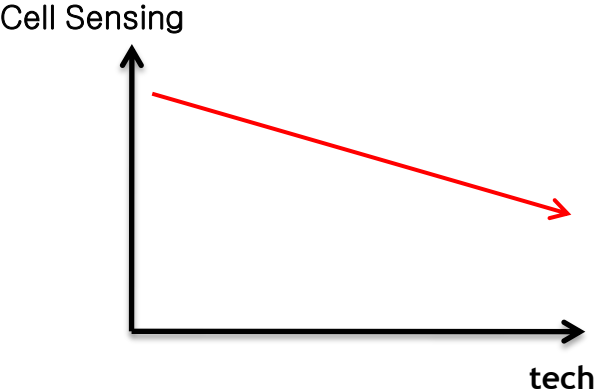
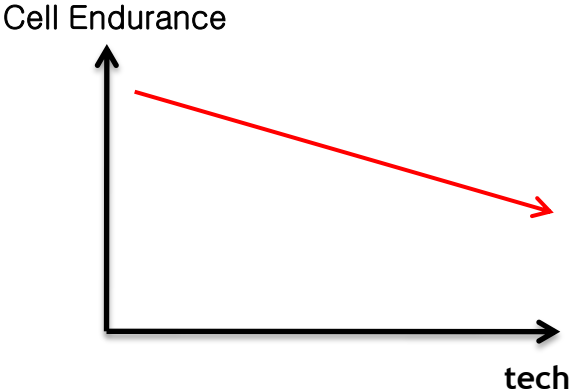
구분	Contents	Data Size	특징
Tiny	FAT File-system data	512 bytes, 1K	<ul style="list-style-type: none"> • File에 대한 위치 정보등 metadata 기록 • Data와 Data 사이에 빈번한 access 발생 • 동일 위치에 대한 빈번한 read/write
Small	OS System files, Application Internet, e-Mail	4K, 8K, 16K, ...	<ul style="list-style-type: none"> • System, Internet caching에 의한 fragmentation 발생 • 빈번한 read/write 발생
Large	Movies, MP3, Photos	4M, 1.4G, 2.1G, 4.5G, ...	<ul style="list-style-type: none"> • 낮은 update 주기 • 반복된 read 발생

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Disadvantage of NAND Flash for Performance

- **Over-Write 불가능**(1-→0가능, 0-→1 불가능)
 - Write를 위해 Erase동작이 선행되어야 함
- **Operation 단위의 차이**
 - Page 단위의 write / read
 - Block 단위의 erase
- **E/W cycling 제한**
 - Wear-leveling 필요
- **Bit Flipping 발생**
 - ECC 처리 필요

NAND Parameter Trend



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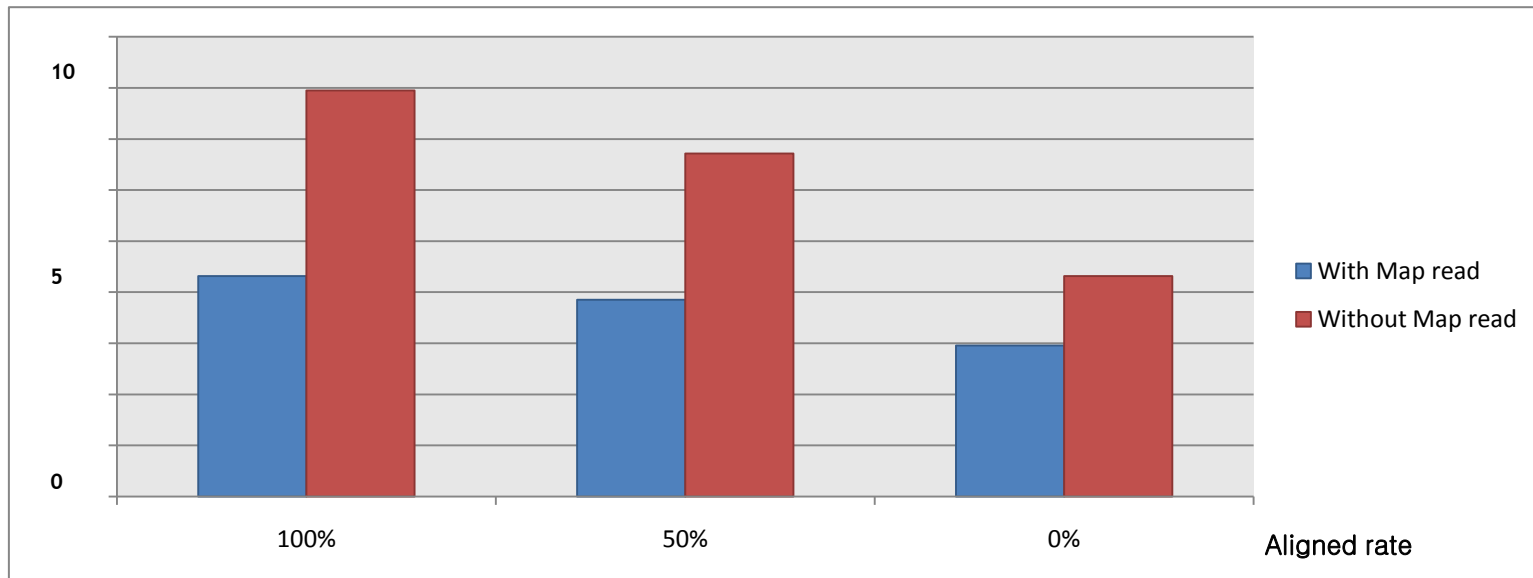
Evolution of FTL Algorithm

- **FTL**은 **Random Performance**향상을 위해 진화 중!!
 - BAST(2002): Log Block과 Data Block이 1:1로 연관
 - FAST(2006): Log Block내의 Data Block에 대한 Page Mapping
 - SAST(2007): Log Block에 연관된 Data Block개수를 제한(N)
 - LAST(2009): Random Log Block을 Hot / Cold로 구분
 - KAST(2009): Log Block Association을 줄이기 위한 Block 할당
- 다음의 **FTL**은?

Random Read Issues

- Key Issues

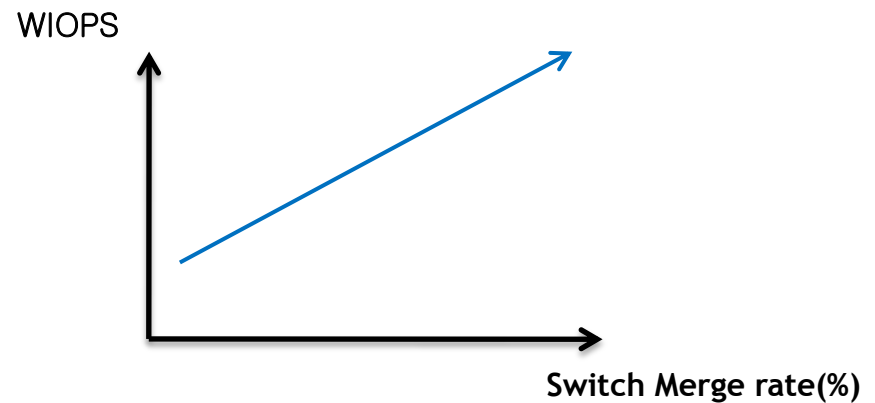
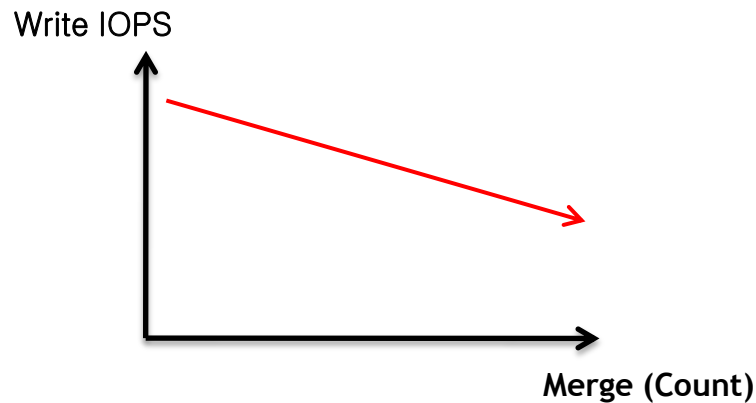
- Mis-aligned 상황 회피
- Map Hit 확률 증대



Random Write Issues

- Key Issues

- Merge 횟수 감소
- Switch/Partial Merge 유도



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Random 성능과 HW 구조

- **NAND parameter**

- ✓ **Page size**

- ✓ **Pages per Block**

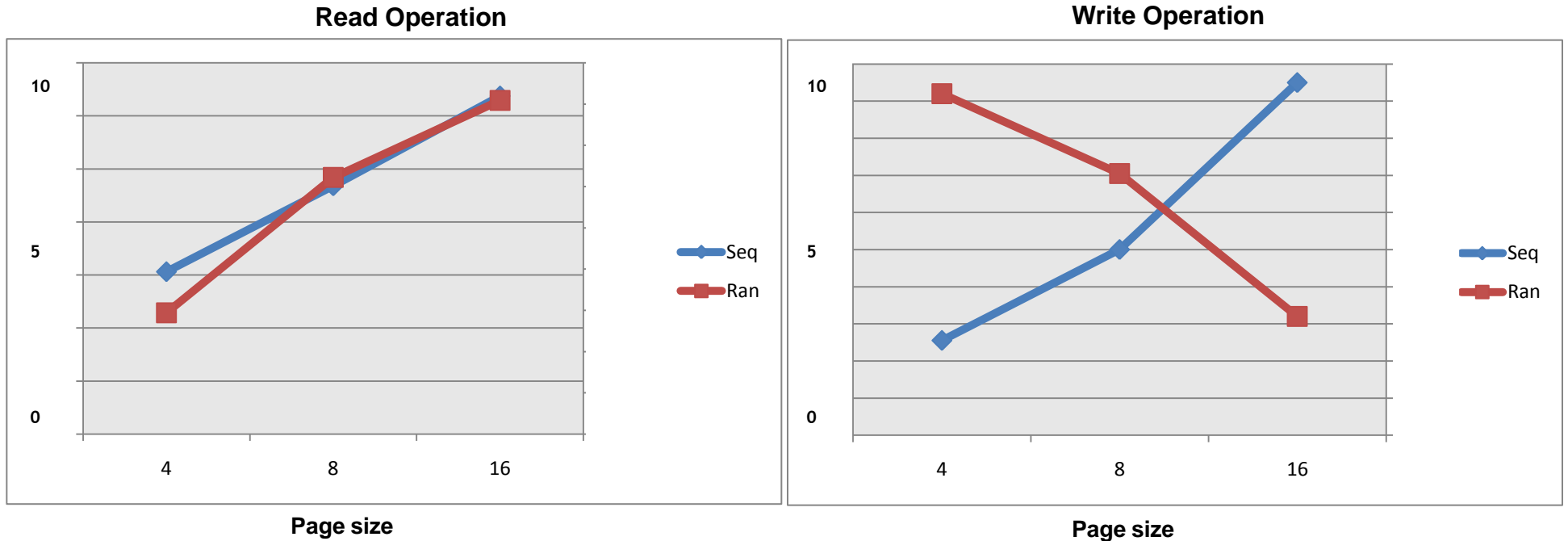
- **Architecture**

- ✓ **Multi-Channel / Multi-Way**

- ✓ **Cache Operation**

- ✓ **Over Provisioning**

Page size에 따른 성능변화



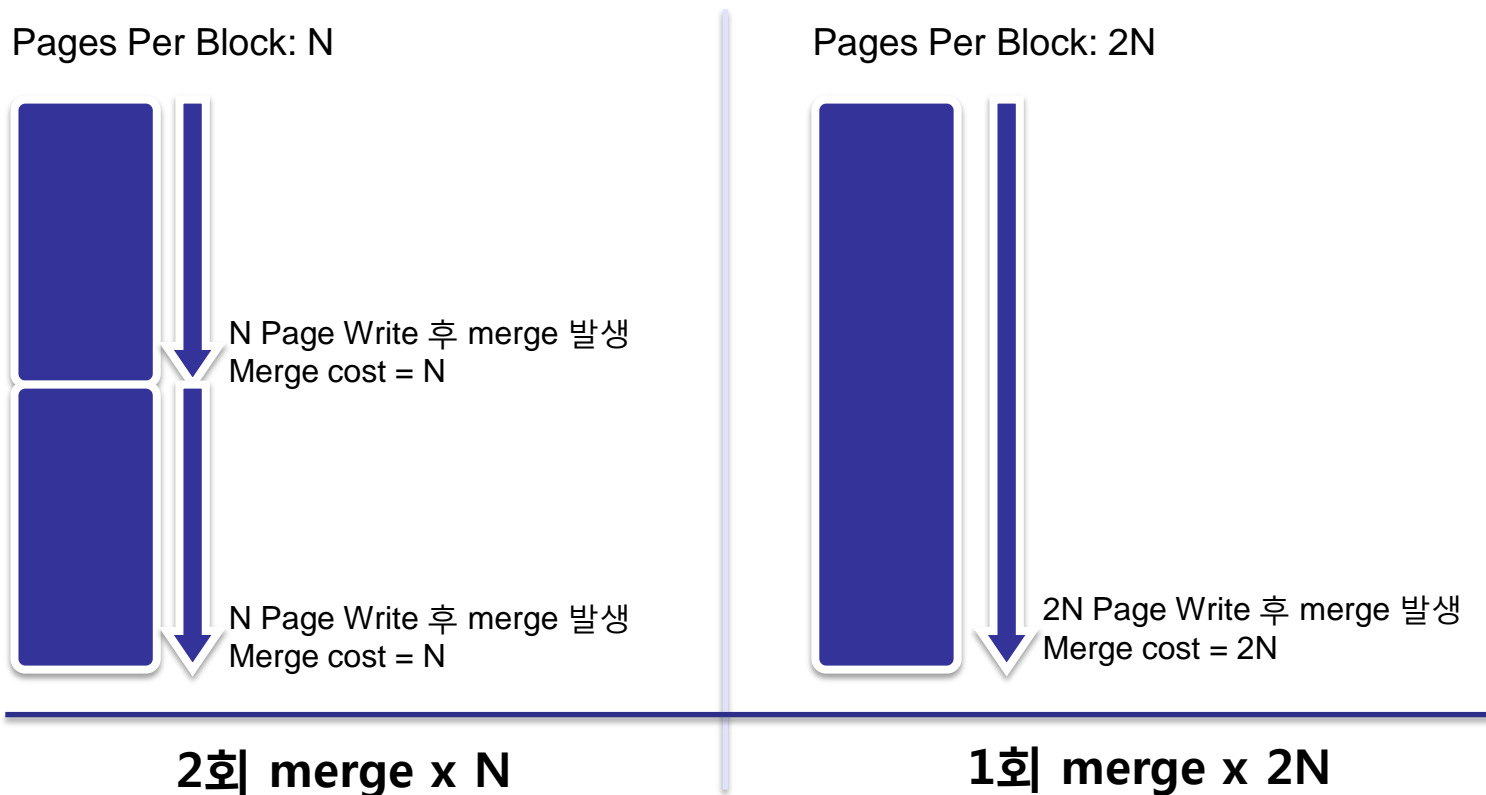
▪ Page size 증가

- ✓ Sequential Throughput 증가
- ✓ Random Read의 경우 Mis-align 감소로 성능향상
- ✓ Random Write의 경우 Log block utilization문제로 성능저하 발생

Pages per Block에 따른 Random 성능

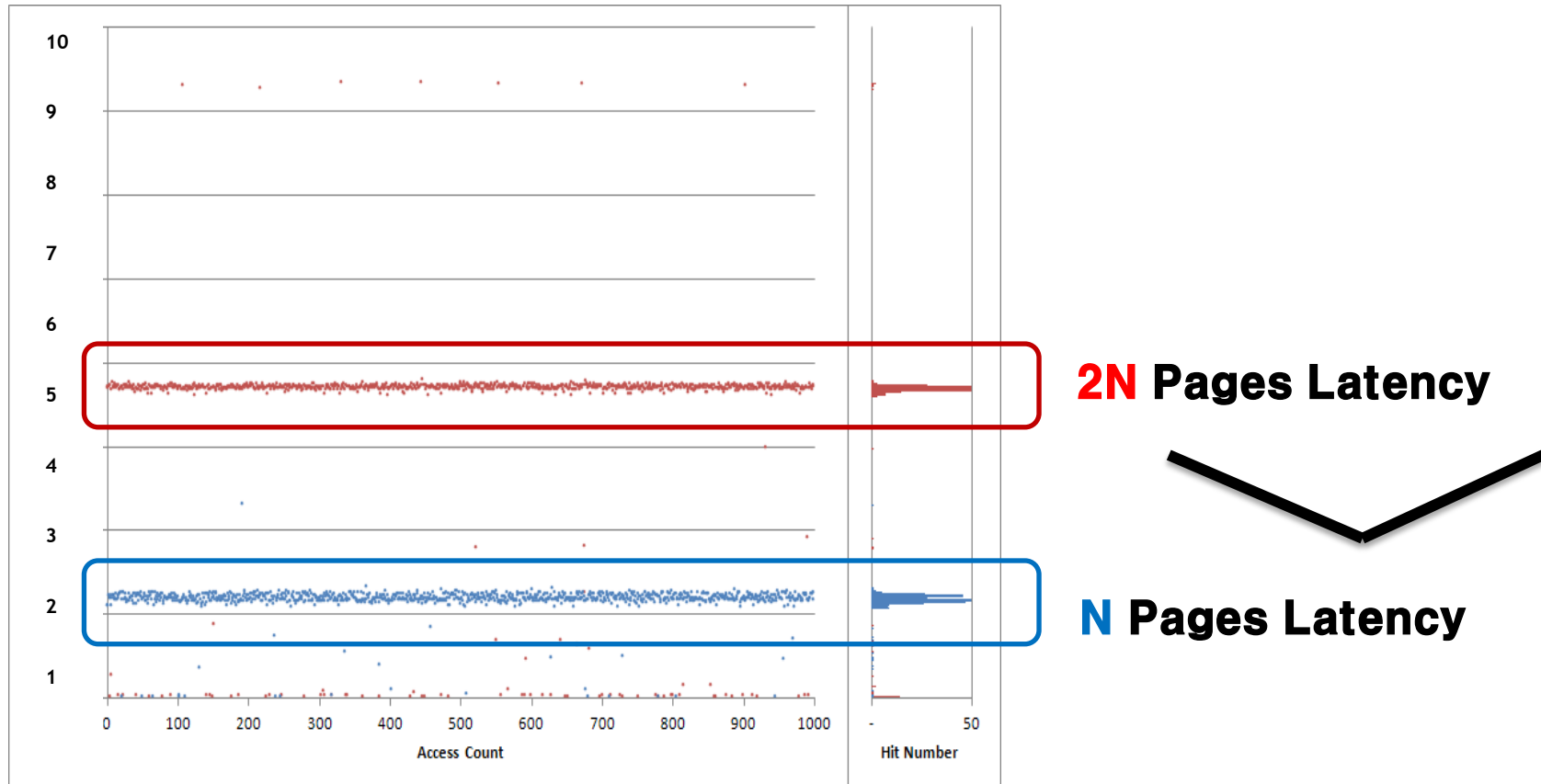
▪ FTL개선으로 Random Performance 저하 최소화 가능

Mapping 방식	성능 저하	비 고
Block mapping	50% 정도 성능 저하	저용량 메모리 사용
Hybrid mapping	0 ~ 5% 저하	eMMC controller
Paged mapping	성능 저하 요소 없음	SSD, Hybrid eMMC



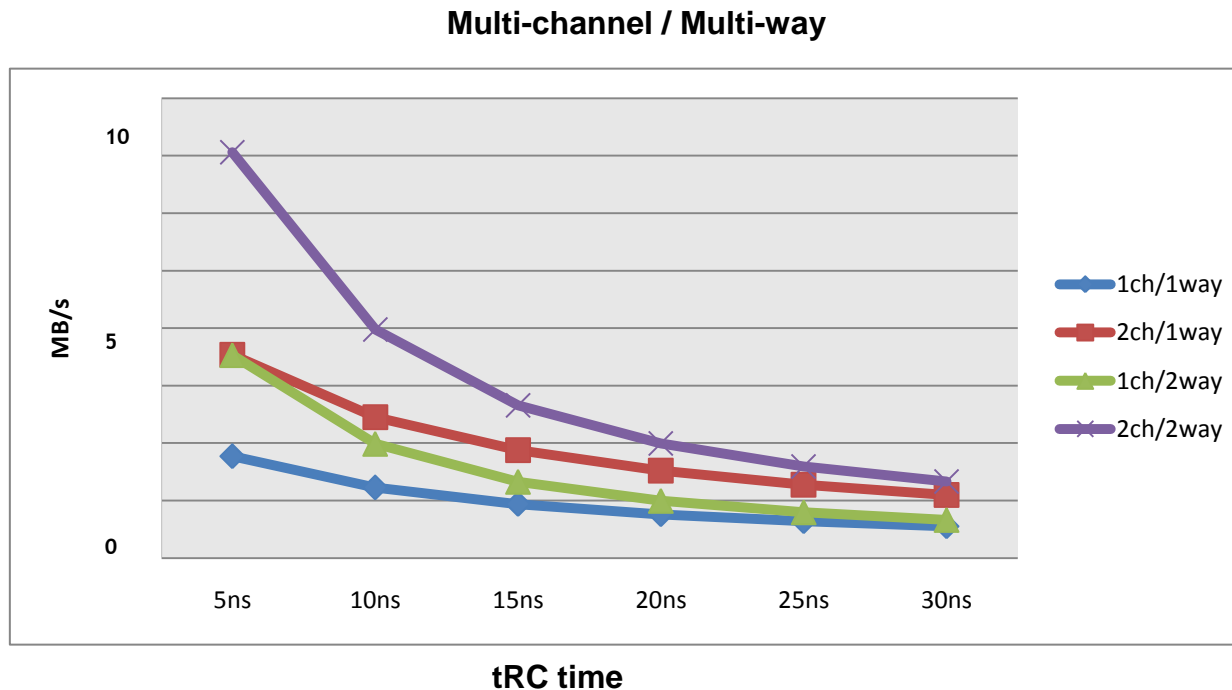
Pages per Block에 따른 Write Latency Time

- **Block copy에 소요되는 시간이 page개수 만큼 증가**
- **이로 인한 응답시간은 상대적으로 증가!!**
- **해결방안은?**



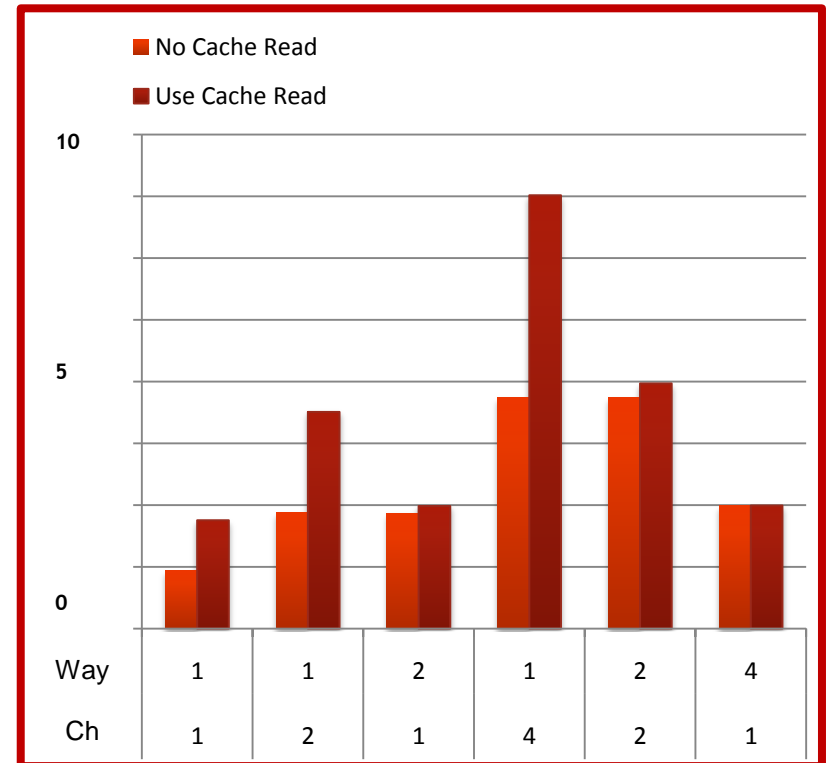
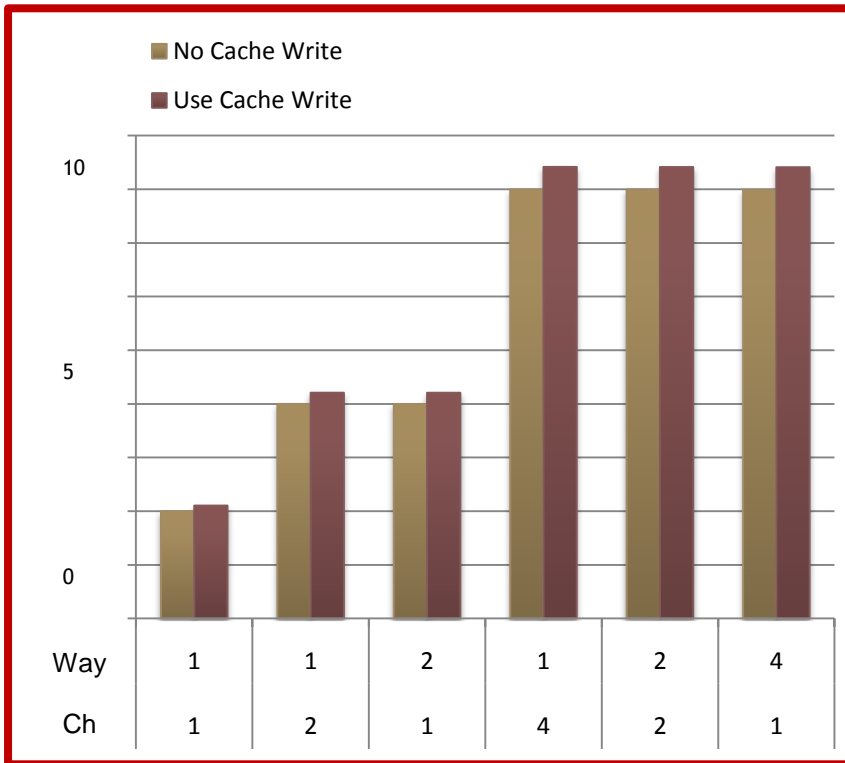
Multi-channel / Multi-Way

- Channel 이 증가하면 **성능 향상**
 - Way가 증가해도 **향상(Channel 이 우세)**
- ✓ 단, Embedded system에서 **Current Consumption 문제로 병렬처리의 한계가 존재함**



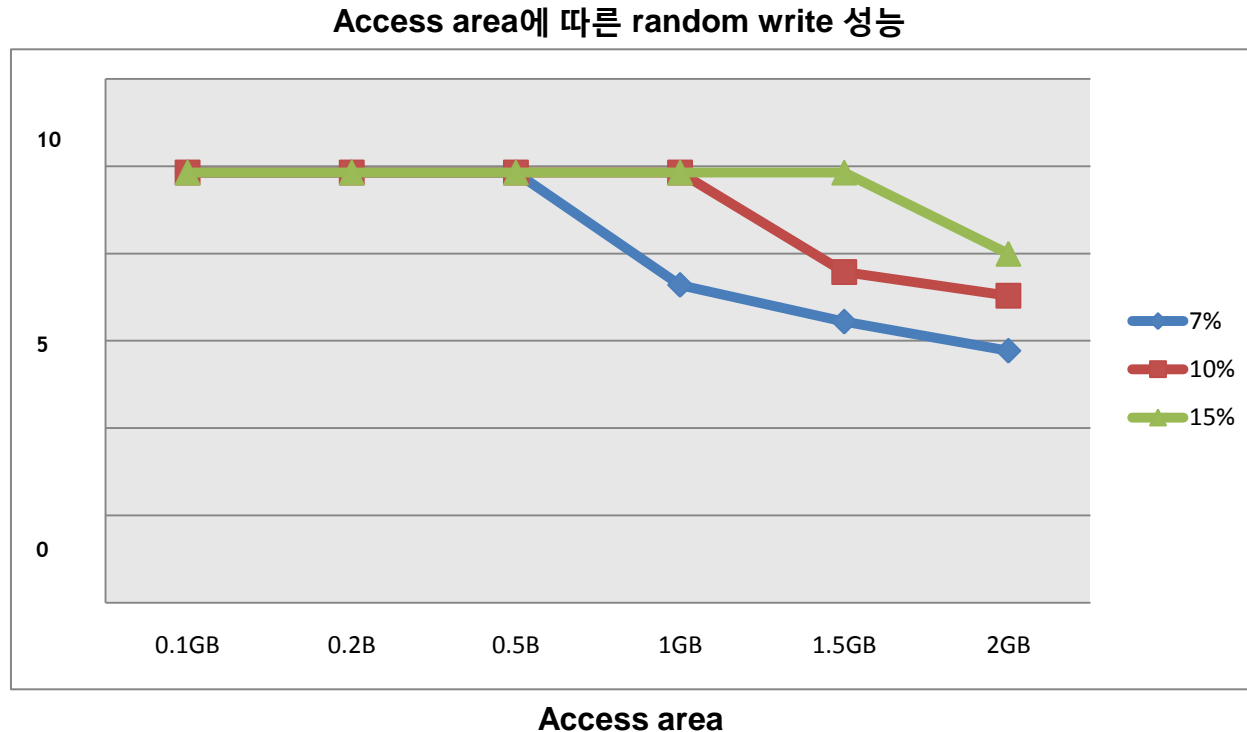
Cache Operation

- Sequential Performance는 Cache Operation이 유용함
- Transfer Time의 비중이 큰 Read Operation에 두드러짐



Over provisioning과 access area 관계

Buffer 영역이 클수록 random performance 향상



Over provisioning 이 R.W 성능을 좌우한다!

Performance 구성 요소

구분	Items		비고
Random performance	HW	<ul style="list-style-type: none"> • tRC/tWC, eMMC clock • tRead • tProgram • tErase • DRAM size 	Cost 증가
	SW	<ul style="list-style-type: none"> • Over provisioning • FTL Algorithm <ul style="list-style-type: none"> ➤ L2P map structure ➤ Buffer block management 	Software algorithm의 복잡도 증가로 Over-head 발생
Sequential performance	HW	<ul style="list-style-type: none"> • Plane, Channel, Way • SDRAM 	Performance와 Power 간의 trade-off
	SW	<ul style="list-style-type: none"> • Parallelism <ul style="list-style-type: none"> ➤ Multi plane operation ➤ Multi channel operation ➤ interleaving operation 	Software 복잡도 증가로 Over-head 발생

Q & A